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Application/Control No.	Applicant(s)/Patent under Reexamination
10/029,310	CELIK ET AL.
Examiner	Art Unit
Dustin Nguyen	2154

SEARCHED			
Class	Subclass	Date	Examiner
715	513, 748	2/14/2007	DN
713	1	2/14/2007	DN
717	103	2/14/2007	DN
345	762	2/14/2007	DN
379	201.04	2/14/2007	DN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
715	513, 716.	2/14/2007	DN
715	748	2/14/2007	DN
709	231	2/14/2007	DN
717 713 345 379 201	103 1 762 04, 201.05	2/14/2007	DN

(INCLUDING SEARCH	DATE	EXMR
search EAST, searches IEEE, ACM and google	2/14/2007	DN
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